

AUIRF2804 AUIRF2804S AUIRF2804L

40V

1.5mΩ®

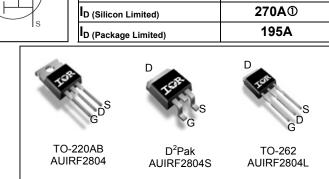
2.0mΩ®

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and wide variety of other applications.



 V_{DSS}

R_{DS(on)}

typ.

max.

G	D	S
Gate	Drain	Source

Base part number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
AUIRF2804	TO-220	Tube	50	AUIRF2804
AUIRF2804L	TO-262	Tube	50	AUIRF2804L
AUIRF2804S D ² -Pak		Tube	50	AUIRF2804S
AUIRF20045	D -Pak	Tape and Reel Left	800	AUIRF2804STRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	270①	
$I_D @ T_C = 100^{\circ}C$ Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)		190	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	195	A
I _{DM}	Pulsed Drain Current ②	1080	
P _D @T _C = 25°C	Maximum Power Dissipation	300	W
	Linear Derating Factor	2.0	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS} Single Pulse Avalanche Energy (Thermally Limited) 3		540	
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value 6	1160	mJ
I _{AR}	Avalanche Current ②	See Fig.15,16, 12a, 12b	А
E _{AR}	Repetitive Avalanche Energy ②		mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ ext{ heta}JC}$	Junction-to-Case		0.50	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{ ext{ heta}JA}$			62	C/W
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount, steady state) 🛛		40	

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*Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	40			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.031		V/°C	Reference to 25°C, I_D = 1mA
R _{DS(on)} SMD	Static Drain-to-Source On-Resistance		1.5	2.0		V _{GS} = 10V, I _D = 75A ④ ⑩
R _{DS(on)} TO-220	Static Drain-to-Source On-Resistance		1.8	2.3	mΩ	V _{GS} = 10V, I _D = 75A ④ ⑩
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	130			S	V _{DS} = 10V, I _D = 75A [®]
1	Drain to Source Lookage Current			20	μA	V _{DS} =40 V, V _{GS} = 0V
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	V _{DS} =40V,V _{GS} = 0V,T _J =125°C
1	Gate-to-Source Forward Leakage			200	n A	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-200	1 11A	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

-		1			1	1	
Q _g	Total Gate Charge		160	240		I _D = 75A [®]	
Q_{gs}	Gate-to-Source Charge		41	62	nC	V _{DS} = 32V	
Q_{gd}	Gate-to-Drain Charge		66	99		V _{GS} = 10V④	
t _{d(on)}	Turn-On Delay Time		13			$V_{DD} = 20V$	
t _r	Rise Time		120		ns	I _D = 75A [®]	
t _{d(off)}	Turn-Off Delay Time		130		115	R _G = 2.5Ω	
t _f	Fall Time		130			V _{GS} = 10V ④	
L _D	Internal Drain Inductance		4.5		nH	Between lead, 6mm (0.25in.)	
L _S	Internal Source Inductance		7.5			from package	
C _{iss}	Input Capacitance		6450			V _{GS} = 0V	
C _{oss}	Output Capacitance		1690			V _{DS} = 25V	
C _{rss}	Reverse Transfer Capacitance		840		ηE	f = 1.0MHz, See Fig. 5	
C _{oss}	Output Capacitance		5350		pF	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$	
C _{oss}	Output Capacitance		1520			$V_{GS} = 0V, V_{DS} = 32V f = 1.0MHz$	
C _{oss eff.}	Effective Output Capacitance		2210			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V \text{ (s)}$	
	Diode Characteristics						

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			270 ①		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			1080		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C,I _S = 75A [®] ,V _{GS} = 0V ④
t _{rr}	Reverse Recovery Time		56	84	ns	T _J = 25°C ,I _F = 75A⑩, V _{DD} = 20V
Q _{rr}	Reverse Recovery Charge		67	100	nC	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{S}+L_{D}$)			

Notes:

- Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- 3 Limited by T_{Jmax}, starting T_J = 25°C, L = 0.24mH, R_G = 25 Ω , I_{AS} = 75A, V_{GS} =10V. Part not recommended for use above this value.
- $\ \ \, \mbox{ Pulse width} \leq 1.0ms; \mbox{ duty cycle} \leq 2\%. \ \ \, \mbox{ }$
- \odot C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- (a) This value determined from sample failure population, starting $T_J = 25^{\circ}C$, L = 0.24mH, $R_G = 25\Omega$, $I_{AS} = 75A$, $V_{GS} = 10V$.
- ⑦ This is applied to D²Pak When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and
- soldering techniques refer to application note #AN-994
- $\ensuremath{\circledast}$ Max R_{DS(on)} for D²Pak and TO-262 (SMD) devices.
- TO-220 device will have an Rth value of 0.45°C/W.
- In All AC and DC test condition based on old Package limitation current = 75A.



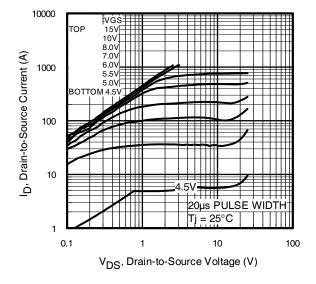


Fig. 1 Typical Output Characteristics

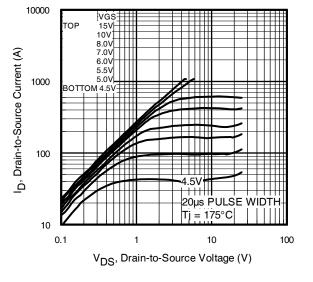


Fig. 2 Typical Output Characteristics

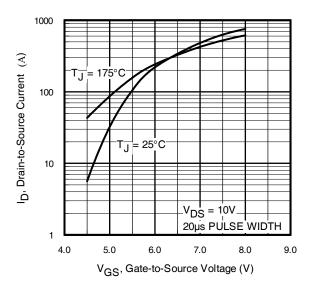
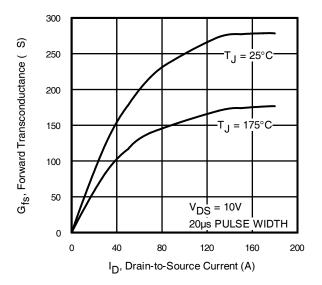
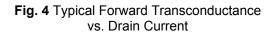
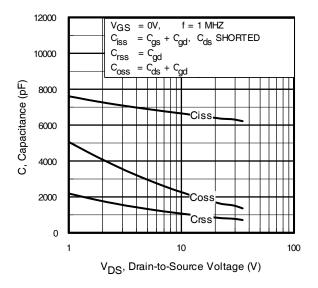


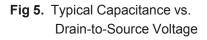
Fig. 3 Typical Transfer Characteristics











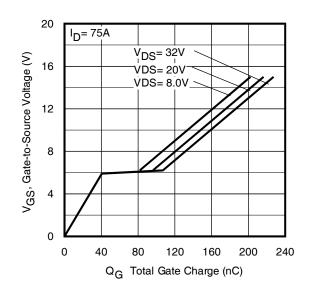


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

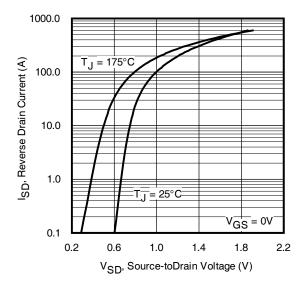


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

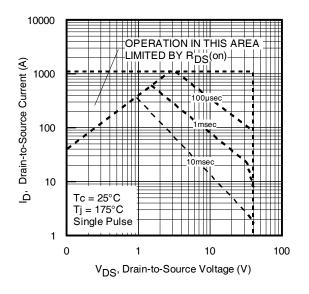


Fig 8. Maximum Safe Operating Area



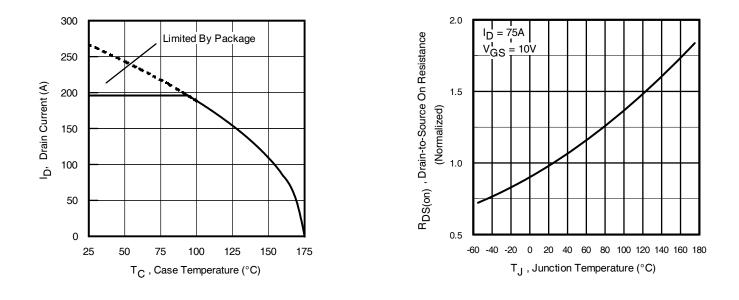


Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

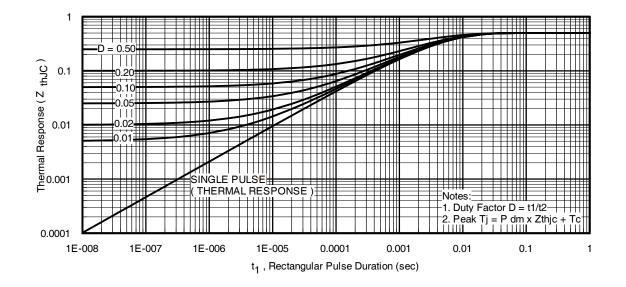


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

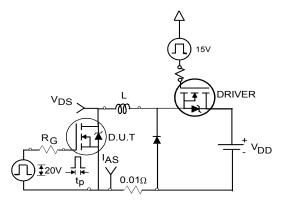


Fig 12a. Unclamped Inductive Test Circuit

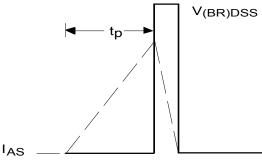
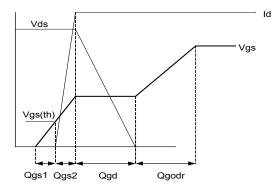
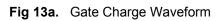


Fig 12b. Unclamped Inductive Waveforms





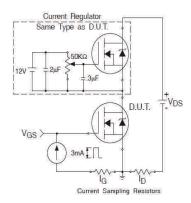


Fig 13b. Gate Charge Test Circuit

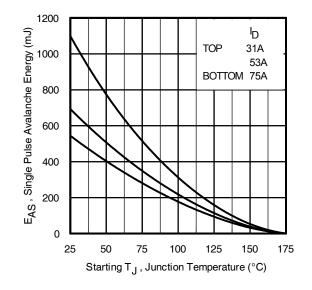


Fig 12c. Maximum Avalanche Energy vs. Drain Current

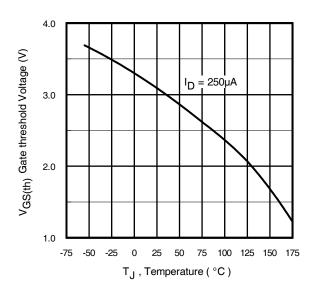


Fig 14. Threshold Voltage vs. Temperature



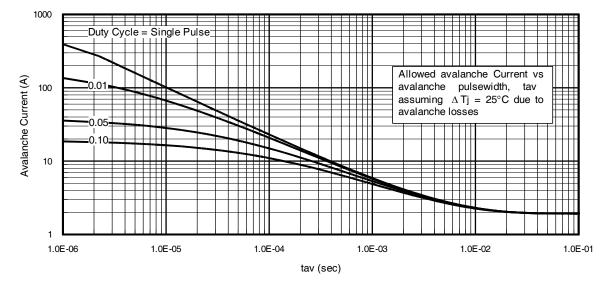


Fig 15. Typical Avalanche Current vs. Pulse width

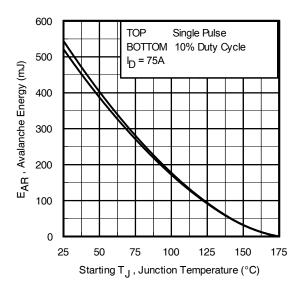


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).
 - tav = Average time in avalanche.
 - D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \textbf{P}_{D \;(ave)} &= 1/2 \; (\; \textbf{1.3} \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; [\textbf{1.3} \cdot \textbf{BV} \cdot \textbf{Z}_{th}] \\ \textbf{E}_{AS \;(AR)} &= \textbf{P}_{D \;(ave)} \cdot \textbf{t}_{av} \end{split}$$

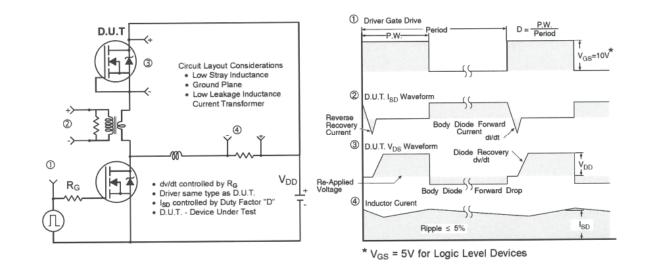


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

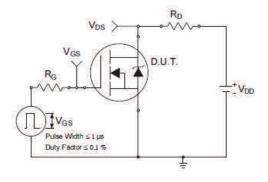


Fig 18a. Switching Time Test Circuit

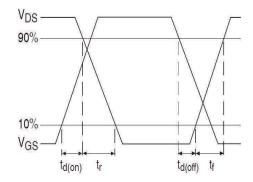
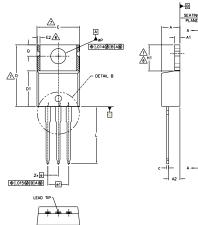


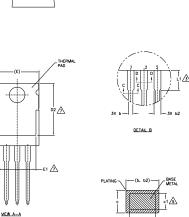
Fig 18b. Switching Time Waveforms

infineon



TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





 $|_{\mathbb{A}}$ ь1.ь3 SECTION C-C & D-D

- NOTES:
- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. 1.-
- 2.-
- 3 -
- DIMENSIONING AND TOLERANGUNG AS FER ASME 114.5 MF 1994. DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS] LEAD DIMENSION AND FINISH UNCONTROLLED IN L1. DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE 4.-MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- <u>/5.-</u> DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.
- 6.-CONTROLLING DIMENSION : INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1 7. – 8.-
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- UTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE. 9.-

	DIMENSIONS				
SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
А	3.56	4.83	.140	.190	
A1	1.14	1.40	.045	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0.97	.015	.038	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
с	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
Ε	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	-	.030	8
е	2.54	2.54 BSC .100 BSC 5.08 BSC .200 BSC		BSC	
e1	5.08	BSC	.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	3.56	4.06	.140	.160	3
ØP	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

LEAD ASSIGNMENTS

<u>HEXFET</u> 1.- GATE 2.- DRAIN 3.- SOURCE

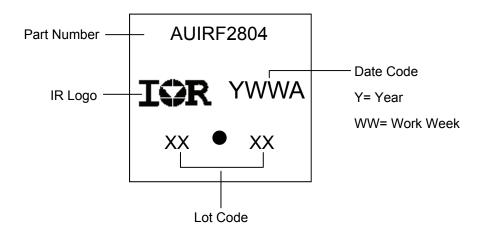
IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

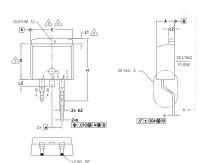
TO-220AB Part Marking Information



TO-220AB package is not recommended for Surface Mount Application.



D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

 ADMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL

 NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED

 AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

PLATING PLA		
SCALE ROTAL AA CAUCE PLANE 0'-8' 1 1 2 1 2 1 2 1 2 1 2 1 2 1 2 1 2 1 2 1	PLATING DI LO	A
CAUCE PLANE CW SCALE 8:1	SCALE: NONE	
	DE TAIL "A"	
	PLANE SCALE 8:1	
		C

S Y	DIMENSIONS				
M B	MILLIM	eters	INC	HES	O T E S
B O L	MIN.	MAX.	MIN.	MAX.	E S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
b	0.51	0.99	.020	.039	
Ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	—	.270	—	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	—	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	—	1.68	-	.066	4
L2	_	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

 DIODES

 1.- ANOBE (TWO DIE) / OPEN (ONE DIE)

 2. 4.- CATHODE

 3.- ANODE

 HEXFET

 1.- GATE

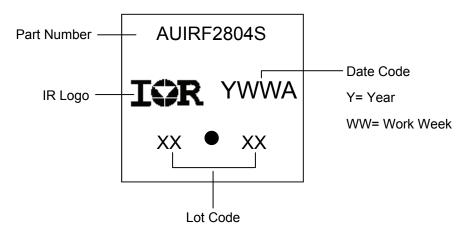
 1.- GATE

 2. 4.- ORRAIN

 3.- SOURCE

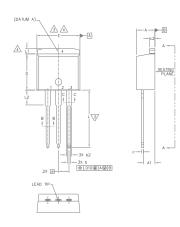
 3.- SURTER

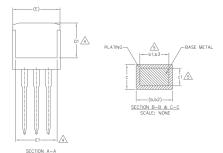
D²Pak (TO-263AB) Part Marking Information





TO-262 Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

LEAD ASSIGNMENTS

IGBTs, CoPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

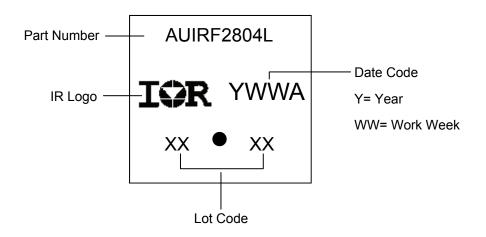
HEXFET DIODES

- 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE 1.- GATE
- 2.- DRAIN 3.- SOURCE 4.- DRAIN



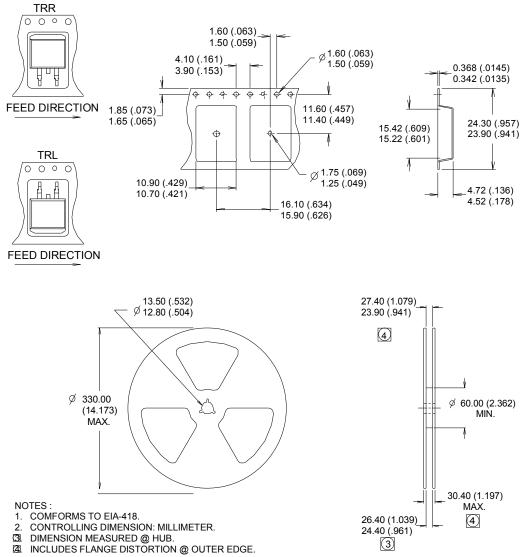
S Y M		N				
B	MILLIMETERS		INC	INCHES		
0 L	MIN.	MAX.	MIN.	MAX.	O T E S	
A	4.06	4.83	.160	.190		
A1	2.03	3.02	.080	.119		
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	-	.270	-	4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	-	.245		4	
е	2.54	BSC	.100	BSC		
L	13.46	14.10	.530	.555		
L1	_	1.65	-	.065	4	
L2	3.56	3.71	.140	.146		

TO-262 Part Marking Information





D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))



4



Qualification Information

		Automotive				
		(per AEC-Q101)				
		is part number(s) passed Automotive qualification. Infineon's consumer qualification level is granted by extension of the higher				
Moisture Sensitivity Level		N/A				
		MSL1				
		WISL I				
Machina Madal	Class M4 [†]					
Machine Model	AEC-Q101-002					
	Class H3A [†]					
Human Body Model	AEC-Q101-001					
	Class C5 [†]					
Charged Device Model	AEC-Q101-005					
RoHS Compliant		Yes				
	Sensitivity Level Machine Model Human Body Model Charged Device Model	Sensitivity Level TO-220AB TO-220AB TO-262 D ² -Pak Machine Model Human Body Model Charged Device Model				

† Highest passing voltage.

Revision History

Date	Comments
9/30/2015	Updated datasheet with corporate template.Corrected ordering table on page 1.
8/22/2017	Corrected part marking on pages 9,10,11.

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